

Notice of References Cited	Application/Control No. 10/582,118		Applicant(s)/Patent Under Reexamination VOLLMANN ET AL.	
	Examiner Jack A. Lane		Art Unit 2185	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-7,467,376	12-2008	Le Metayer et al.	717/143
*	C	US-7,114,646	10-2006	Hillhouse, Robert D.	235/375
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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